

- contributing
- courses
- epub
- fluotime250
- general
 - advantages_and_disadvantages_of_two_photon_excitation_tpe
 - community_news
 - fluorescence_correlation_spectroscopy-a_short_introduction
- glossary
 - alex
 - aotf
 - asymptotic_standard_errors
 - bdf
 - bifl
 - bootstrap_method
 - bootstrap
 - cfd
 - chi_square_management
 - chi_square
 - convolution
 - dead_time
 - deconvolution
 - differential_count_rate
 - fast_flim
 - fast_lifetime
 - fastlt
 - fcs
 - flim
 - fluorescence_lifetime
 - frap
 - fret
 - fwhm
 - hybrid_pmt
 - irf
 - least_squares
 - marquardt-levenberg
 - mcp
 - mcs
 - mle
 - monte_carlo
 - nim
 - od
 - pie
 - pile-up_effect
 - pmt
 - poisson_distribution

- pre-histogrammed_image
- pulsed_interleaved_excitation
- deconvolution
- residuals
- spad
- spads
- support_plane_analysis
- t2-mode
- t3-mode
- tcspc
- tttr
- howto
 - 2ffcs
 - align_beam_backreflection
 - antibunching_measurements
 - avoid_pile_up_effect_in_flim_measurements
 - calculate_and_fit_fcs_traces_with_the_fcs_script
 - calculate_fccs_trace_with_the_grouped_fcs_script
 - calculate_ratiometric_fret_images
 - calculate_ratiometric_single_pair_fret_distributions_using_the_pie-fret_script
 - calculate_ratiometric_single_pair_fret_distributions
 - calibrate_the_confocal_volume_for_fcs_using_the_fcs_calibration_script
 - check_overlap_of_different_color_confocal_volumes
 - data_file_import
 - determination_of_the_focal_width_with_the_focal
 - diamond_nv_centers
 - exchange_dichroic_mt200
 - flim_fret_calculation_for_multi_exponential_donors
 - flim_measurement_using_a_nikon_a1_with_a_flim_and_fcs_upgrade
 - flim-fret_calculation_for_single_exponential_donors
 - flim-fret_measurement_using_an_olympus_fv1200_with_a_flim_and_fcs_upgrade
 - how_to_measure_the_instrument_response_function_irf
 - how_to_work_with_the_instrument_response_function_irf
 - intensity_time_trace_analysis
 - lifetime_fitting_using_the_flim_analysis
 - lifetime_fitting_using_the_tcpsc_fitting_script
 - lifetime-fitting_using_the_flim_script
 - lifetime-fitting_using_the_rapid_deconvolution_algorithm
 - measuring_quantum_yield
 - mt200everyday_alignment
 - mt200fcs
 - mt200fundamental_alignement
 - pattern_matching
 - performing_an_fcs_measurement_with_an_olympus_fv1200_upgrade_kit
 - phasor_analysis
 - deconvolution_fit
 - recording_a_fluorescence_lifetime_image_flim_stack_with_a_lsm_upgrade_kit_on_a_nikon_a1
 - registering_new_scripts
 - roi_fitting_using_the_flim_script
 - select_the_correct_pinhole_size
 - separation_of_2_species_with
 - symphotime_tips_and_tricks
 - t3r_antibunching_-slow_decay
 - update
 - using_the_anisotropy_image_script
 - using_the_antibunching_script

- [using_the_flcs_script_for_spectral_crosstalk_removal_via_flccs](#)
- [visualizing_dynamics_using_the_multiframe-flim_script](#)
- [visualizing_dynamics_with_the_multi_frame_flim_analysis](#)
- [playground](#)
 - [test](#)
- [products](#)
 - [hydraharp_400](#)
 - [microtime](#)
 - [picoharp_300](#)
 - [sepia_ii](#)
 - [syphotime64](#)
 - [tcspc_electronics](#)
- [software](#)
 - [easytau](#)
 - [fcs_viewer](#)
 - [flimfit](#)
 - [fluofit](#)
 - [pycorrfit](#)
 - [supported_mt200_pc_configuration_for_syphotime_32](#)
 - [supported_mt200_pc_configuration_for_syphotime_64](#)
 - [syphotime_32](#)
 - [syphotime](#)
 - [syphotime64](#)
- [support](#)
 - [configuring_syphotime64_after_installation](#)
 - [supported_mt200_pc_configuration_for_syphotime_32](#)
 - [supported_mt200_pc_configuration_for_syphotime_64](#)
 - [tcspc_external_markers](#)
- [technical_docs](#)
 - [beampath_of_the_zeiss_lsm700](#)
- [wiki](#)
 - [dokuwiki](#)
 - [ebook](#)
 - [syntax](#)
 - [welcome](#)
- [writingroom](#)
- [applications](#)
- [basics](#)
- [beampath_of_the_zeiss_lsm880](#)
- [contributions](#)
- [contributions12](#)
- [create_time_gated_image](#)
- [data_analysis](#)
- [flim_fcs_using_olympus_fluoview_fv3000_lsm_upgrade_kit](#)
- [fluorescence_lifetime_measurements_using_the_fluotime_300](#)
- [fluorophores_and_samples](#)
- [fullindex](#)
- [imprint](#)
- [interfacing_time_resolved_spectrometer_fluotime_300_microscope_microtime_100](#)
- [laser_safety_instructions](#)
- [legal_information](#)
- [lsm710](#)
- [measurement_hardware_instrumentation](#)
- [privacy_policy](#)
- [some_origins_of_multiexponential_decays_for_single_dyes](#)

- [supported_th260_pc](#)
- [synchrotron_application](#)
- [synchrotron_applications](#)
- [tutorials](#)
- [video_tutorials](#)

Copyright of this document belongs to PicoQuant GmbH. No parts of it may be reproduced, translated or transferred to third parties without written permission of PicoQuant GmbH. All information given here is reliable to our best knowledge. However, no responsibility is assumed for possible inaccuracies or omissions. Specifications and external appearances are subject to change without notice.



PicoQuant GmbH
Rudower Chaussee 29 (IGZ)
12489 Berlin
Germany

P +49-(0)30-1208820-89
F +49-(0)30-1208820-90
info@picoquant.com
www.picoquant.com